International
IOR Rectifier

IRF250
JANTX2N6766
JANTXV2N6766
[REF:MIL-PRF-19500/543]
200V, N-CHANNEL

REPETITIVE AVALANCHE AND dv/dt RATED
HEXFET® TRANSISTORS
THRU-HOLE (TO-204AA/AE)

TO-3

Product Summary

Part Number	BV_{DSS}	$R_{DS(on)}$	I_D
IRF250	200V	0.085Ω	30A

The HEXFET® technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry and unique processing of this latest "State of the Art" design achieves: very low on-state resistance combined with high transconductance; superior reverse energy and diode recovery dv/dt capability.

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of paralleling and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

Features:

- Repetitive Avalanche Ratings
- Dynamic dv/dt Rating
- Hermetically Sealed
- Simple Drive Requirements
- Ease of Paralleling

Absolute Maximum Ratings

	Parameter		Units
I_D @ V_{GS} = 10V, T_C = 25°C	Continuous Drain Current	30	A
I_D @ V_{GS} = 10V, T_C = 100°C	Continuous Drain Current	19	
I_{DM}	Pulsed Drain Current ①	120	
P_D @ T_C = 25°C	Max. Power Dissipation	150	W
	Linear Derating Factor	1.2	W/°C
V_{GS}	Gate-to-Source Voltage	±20	V
E_{AS}	Single Pulse Avalanche Energy ②	500	mJ
I_{AR}	Avalanche Current ①	30	A
E_{AR}	Repetitive Avalanche Energy ①	15	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
T_J T_{STG}	Operating Junction Storage Temperature Range	-55 to 150	°C
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)	
	Weight	11.5 (typical)	g

For footnotes refer to the last page

01/22/01

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Typ	Max	Units	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	200	—	—	V	V_{GS} = 0V, I_D = 1.0mA
$\Delta BV_{DSS}/\Delta T_J$	Temperature Coefficient of Breakdown Voltage	—	0.29	—	V/°C	Reference to 25°C, I_D = 1.0mA
$R_{DS(on)}$	Static Drain-to-Source On-State Resistance	—	—	0.085	Ω	V_{GS} = 10V, I_D =19A ④
		—	—	0.090		V_{GS} =10V, I_D =30A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	V_{DS} = V_{GS}, I_D =250μA
g_{fs}	Forward Transconductance	9.0	—	—	S (℧)	V_{DS} > 15V, I_{DS} =19A ④
I_{DSS}	Zero Gate Voltage Drain Current	—	—	25	μA	V_{DS}=160V, V_{GS}=0V
		—	—	250		V_{DS} =160V V_{GS} = 0V, T_J = 125°C
I_{GSS}	Gate-to-Source Leakage Forward	—	—	100	nA	V_{GS} =20V
I_{GSS}	Gate-to-Source Leakage Reverse	—	—	-100		V_{GS} =-20V
Q_g	Total Gate Charge	55	—	115	nC	V_{GS} =10V, ID=30A V_{DS} =100V
Q_{gs}	Gate-to-Source Charge	8	—	22		
Q_{gd}	Gate-to-Drain (‘Miller’) Charge	30	—	60		
$t_{d(on)}$	Turn-On Delay Time	—	—	35	ns	V_{DD} =100V, I_D =30A, R_G =2.35Ω
t_r	Rise Time	—	—	190		
$t_{d(off)}$	Turn-Off Delay Time	—	—	170		
t_f	Fall Time	—	—	130		
$L_S + L_D$	Total Inductance	—	6.1	—	nH	Measured from the center of drain pad to center of source pad
C_{iss}	Input Capacitance	—	3500		pF	V_{GS} = 0V, V_{DS} =25V f = 1.0MHz
C_{oss}	Output Capacitance	—	700	—		
C_{rss}	Reverse Transfer Capacitance	—	110	—		

Source-Drain Diode Ratings and Characteristics

	Parameter	Min	Typ	Max	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	30	A	
I_{SM}	Pulse Source Current (Body Diode) ①	—	—	120		
V_{SD}	Diode Forward Voltage	—	—	1.9	V	T_j = 25°C, I_S =30A, V_{GS} = 0V ④
t_{rr}	Reverse Recovery Time	—	—	950	nS	T_j = 25°C, I_F = 30A, di/dt ≤100A/μs V_{DD} ≤50V ④
Q_{RR}	Reverse Recovery Charge	—	—	9.0	μc	
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L_S + L_D.				

Thermal Resistance

	Parameter	Min	Typ	Max	Units	Test Conditions
R_{thJC}	Junction to Case	—	—	0.83	°C/W	
R_{thJA}	Junction to Ambient	—	—	30		Typical socket mount

For footnotes refer to the last page

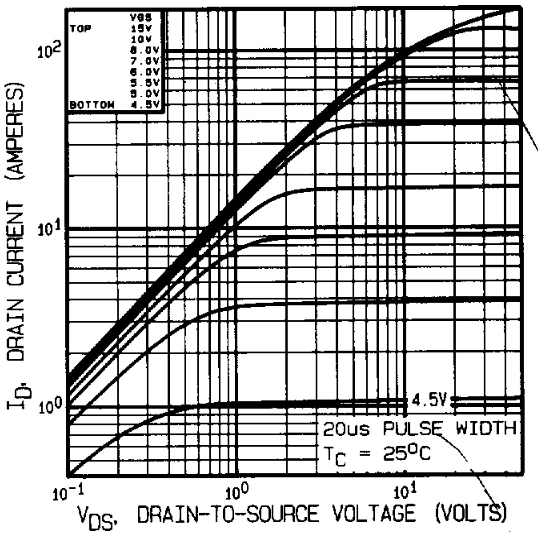


Fig 1. Typical Output Characteristics

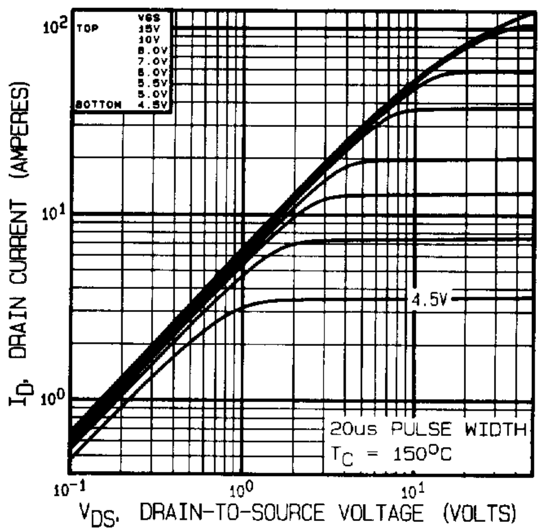


Fig 2. Typical Output Characteristics

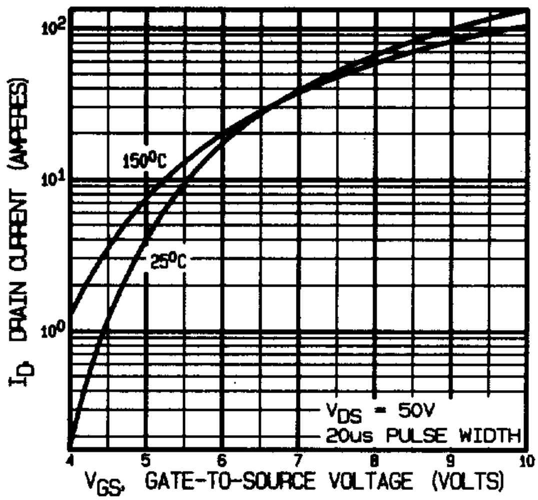


Fig 3. Typical Transfer Characteristics

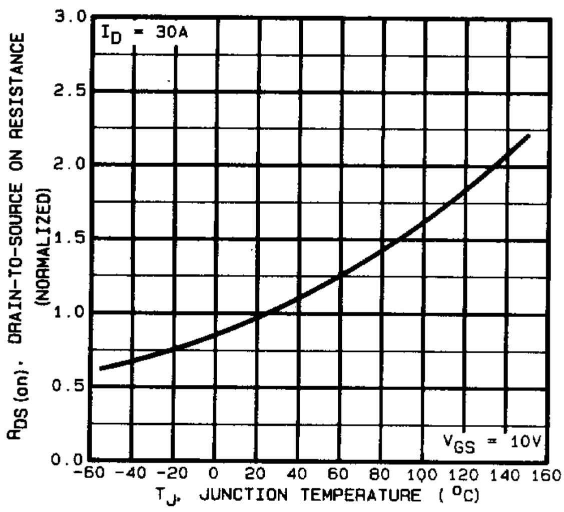


Fig 4. Normalized On-Resistance Vs. Temperature

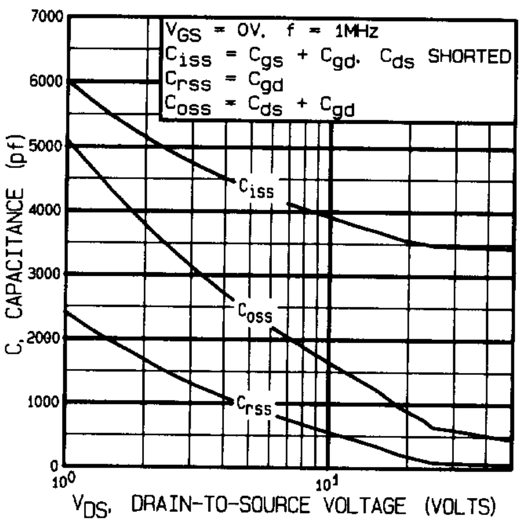


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

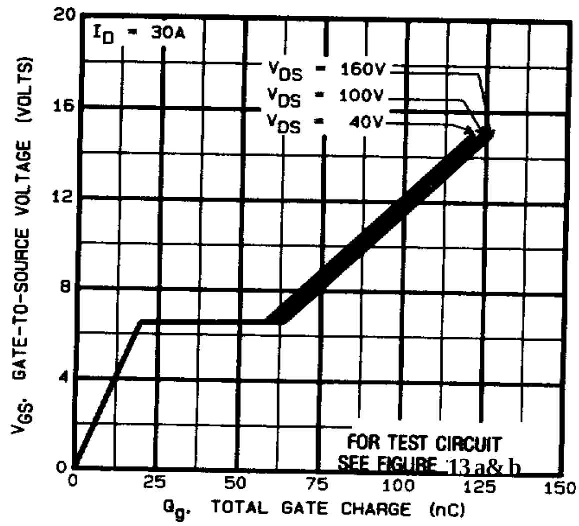


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

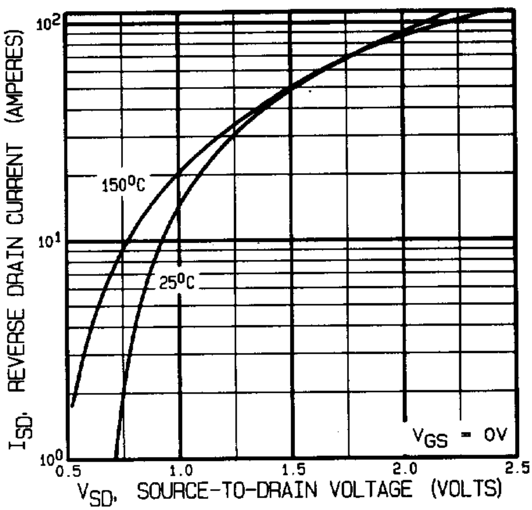


Fig 7. Typical Source-Drain Diode Forward Voltage

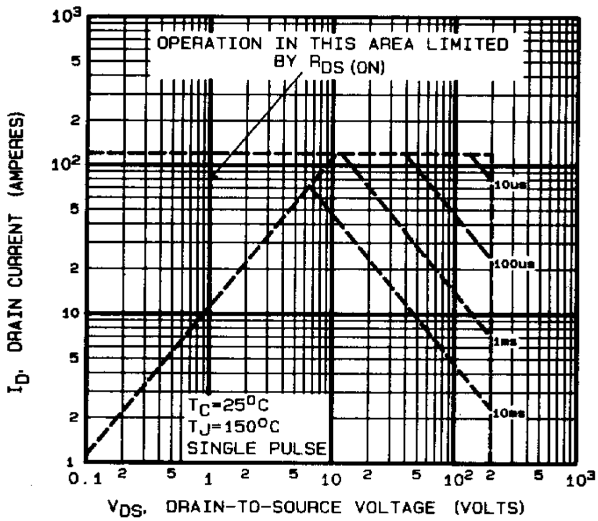


Fig 8. Maximum Safe Operating Area

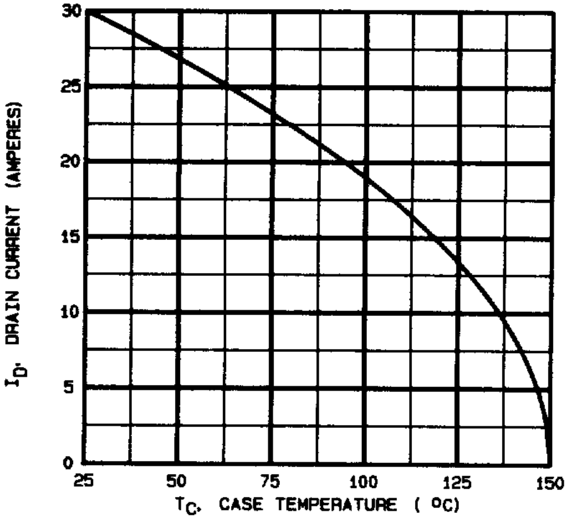


Fig 9. Maximum Drain Current Vs. Case Temperature

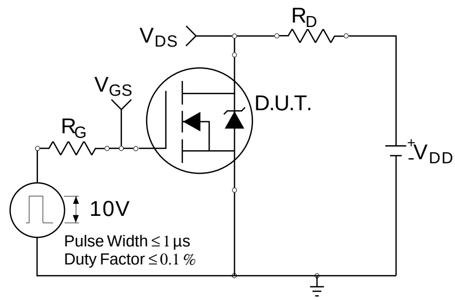


Fig 10a. Switching Time Test Circuit

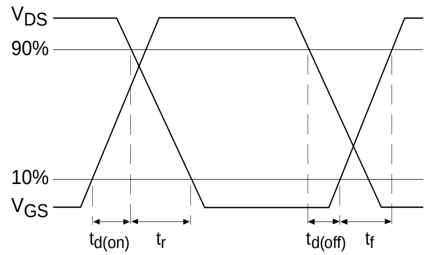


Fig 10b. Switching Time Waveforms

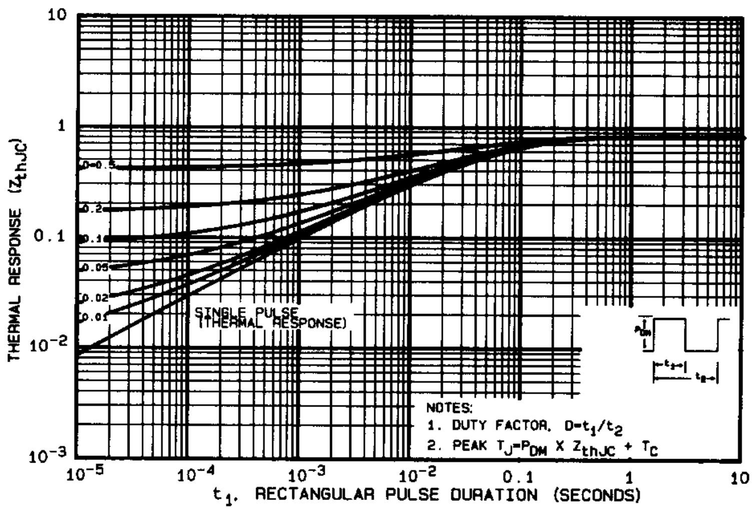


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

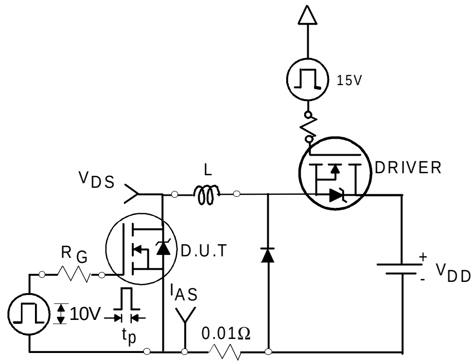


Fig 12a. Unclamped Inductive Test Circuit

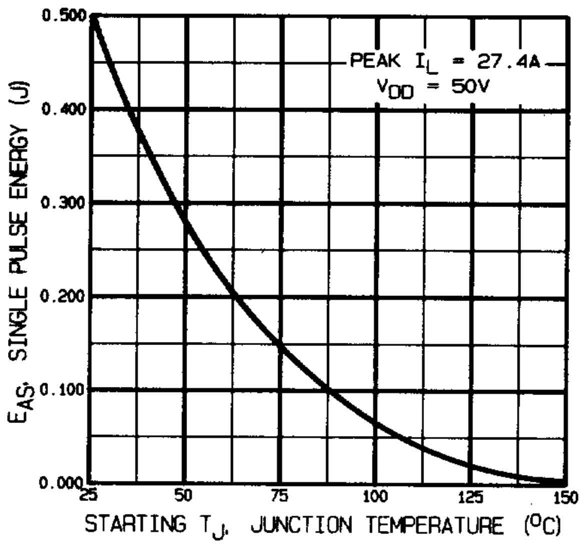


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

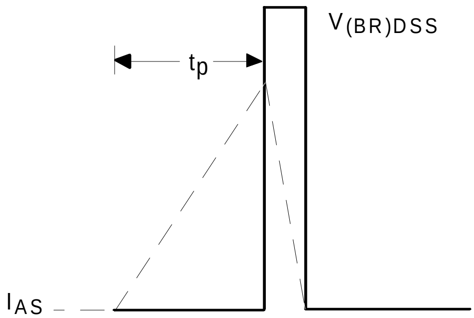


Fig 12b. Unclamped Inductive Waveforms

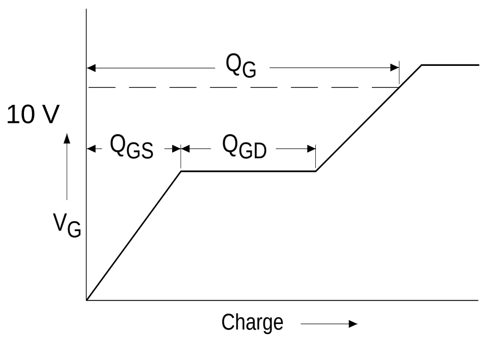


Fig 13a. Basic Gate Charge Waveform

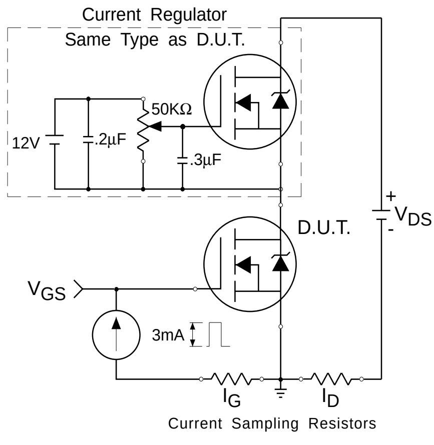


Fig 13b. Gate Charge Test Circuit

Foot Notes:

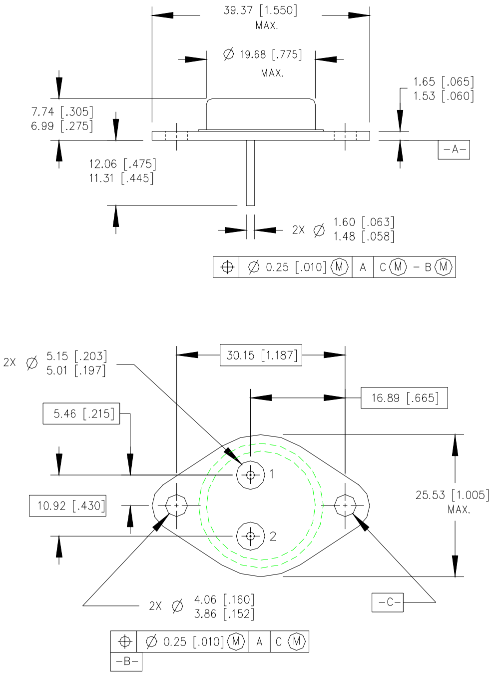
① Repetitive Rating; Pulse width limited by maximum junction temperature.

② V_{DD} =50V, starting T_J = 25°C, Peak I_L = 30A,

③ $I_{SD} \le 30A$, di/dt ≤190A/µs, $V_{DD} \le$ 200V, $T_J \le$ 150°C Suggested RG =2.35 Ω

④ Pulse width ≤ 300 µs; Duty Cycle ≤ 2%

Case Outline and Dimensions —TO-204AE (Modified TO-3)



PIN ASSIGNMENTS

1 – SOURCE
2 – GATE
3 – DRAIN (CASE)

NOTES:

1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M–1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
4. OUTLINE CONFORMS TO JEDEC OUTLINE TO–204AE.

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